

**Search Notes**

Application/Control No.

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Examiner

Hau V. Phan

Applicant(s)/Patent under  
Reexamination

GAUKEL ET AL.

Art Unit

3618

**SEARCHED**

Class	Subclass	Date	Examiner
180	268 269 270	6/20/2007	HP
	271		
280	802	6/20/2007	HP
	801		
	806		
	734		
	735		
701	46	6/20/2007	HP
	45		
	36		
342	72	6/20/2007	HP
	107		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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